



SEE characterization on Operational Amplifiers

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1. Products characteristics
2. Test definitions
3. Experimental results
4. Conclusion

1. Products characteristics



Two operational amplifiers have been tested:

- **RHF43B**: Rad-hardened **precision** bipolar single operational amplifier, in **2 μ m BiCMOS** technology.
Voltage Feedback Operational Amplifier.
- **RHF310**: Rad-hardened **high-speed** bipolar single operational amplifier, in **0.25 μ m BiCMOS** technology.
Current Feedback Operational Amplifier.

	RHF43B Precision VFA	RHF310 High-Speed CFA
V_{CC}	4 to 14V	4.5 to 5.5V
V_{IO}	100 μ V	1.7mV
I_{CC}	2.3mA	400 μ A
-3dB Bandwidth	$A_V=+5$ 2MHz	$A_V=+2$, $R_{fb}=3k\Omega$ 120MHz
Slew Rate	2.85V/ μ s	115V/ μ s

2. Test definitions



- SEL: @125°C, Fluence=1x10⁷#/cm², 2 parts tested / ref.

- **RHF43B:** RADEF (Finland),
LET_{eff}=120MeV.cm²/mg
Range=48μm
Flux ~ 2E+04ions/cm²

Config	V _{CC}	V _{IN}	V _{OUT}
Non Inv	± 7V	6.5V	Saturated
Non Inv	± 7V	-6.5V	Saturated
Non Inv	± 7V	0V	Non Saturated
Inverting	± 7V	2V	Saturated
Inverting	± 7V	-2V	Saturated
Inverting	± 7V	0V	Non Saturated

- **RHF310:** LBNL (USA)
LET_{eff}=110.9MeV.cm²/mg
Range=60μm
Flux ~ 2E+05ions/cm²

Config	V _{CC}	V _{IN}	f (MHz)	V _{OUT}
Non Inv	± 2.8V	2V _{p-p}	5	Saturated
Non Inv	± 2.8V	0.5V _{p-p}	5	Non Sat
Inverting	± 2.8V	2V _{p-p}	5	Saturated
Inverting	± 2.8V	0.6V _{p-p}	5	Non Sat

2. Test definitions



- SET: @T_{amb}.
 - **RHF43B**: HIF (Belgium),
Ions cocktail:

Ion	Energy (MeV)	LET (MeV.cm ² /mg)	Range (Si) (μm)
22 Ne +7	235	3.30	199
41 Ar +12	372	10.10	119
83 Kr +25	756	32.40	92
132 Xe +26	459	55.90	43

Configurations:

Config	V _{CC} (V)	V _{IN} (V)	V _{OUT} (V)
Inverting	±7V	±1.25V	±5V
		0V	0V
Non-Inverting	±7V	±0.8V	±5V
		0V	0V
Subtracting	±1.5V	±1.9V	0V
		0V	0V

2. Test definitions



- SET: @T_{amb}.
 - **RHF310**: LBNL (USA),
Ions cocktail:

Ion	Energy (MeV)	LET (MeV.cm ² /mg)	Range (Si) (μm)
22 Ne +6	216.28	3.49	174.6
40 Ar +11	400.00	9.74	130.1
86 Kr +18	885.59	30.86	109.9
136 Xe +34	1232.55	58.78	90.0

Configurations:

Config	V _{CC} (V)	V _{IN} (V)	f (MHz)	V _{OUT} (V)
Inverting	±2.8V	0.6V _{P-P}	5	±1.5V
Non-Inverting	±2.8V	0.5V _{P-P}	5	±1.5V
Subtracting	±2.2V	2V _{P-P}	5	0V

3. Experimental results

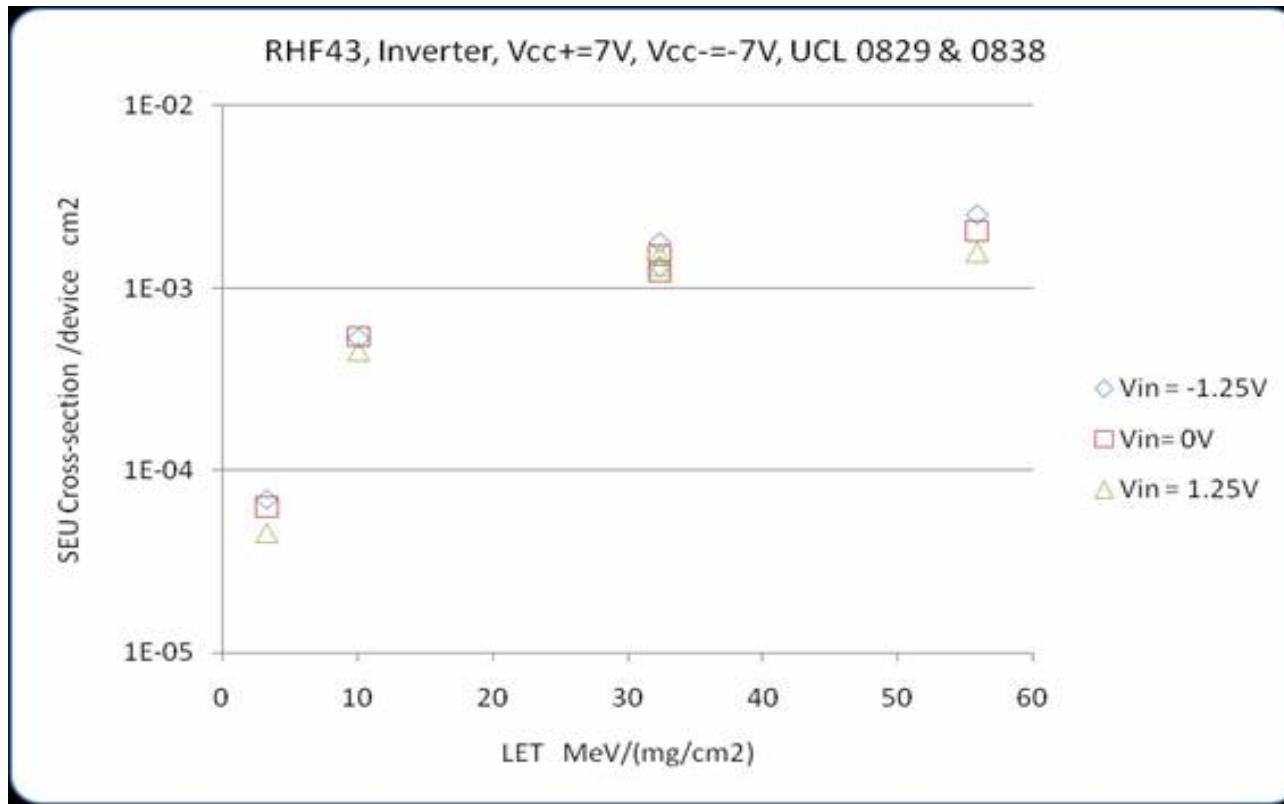


- RHF43B:
 - No SEL @ 110MeV.cm²/mg, 125°C
 - SET worst cases:

Config	V _{CC} (V)	V _{IN} (V)	Amplitude (V)	Duration (μs) (50% of the amplitude)
Subtracting	±1.5V	+1.9V	1.10	1.05
		-1.9V	1.11	0.85
		0V	1.11	0.95
Inverting	±7V	+1.25V	-6.64	1.8
		-1.25V	-10.1	2.5
		0V	-6.85	1.75
Non-Inverting	±7V	+0.8V	-2.07	0.6
		-0.8V	3.12	3.15
		0V	-6.88	1.85

3. Experimental results

- RHF43B: Inverting configuration

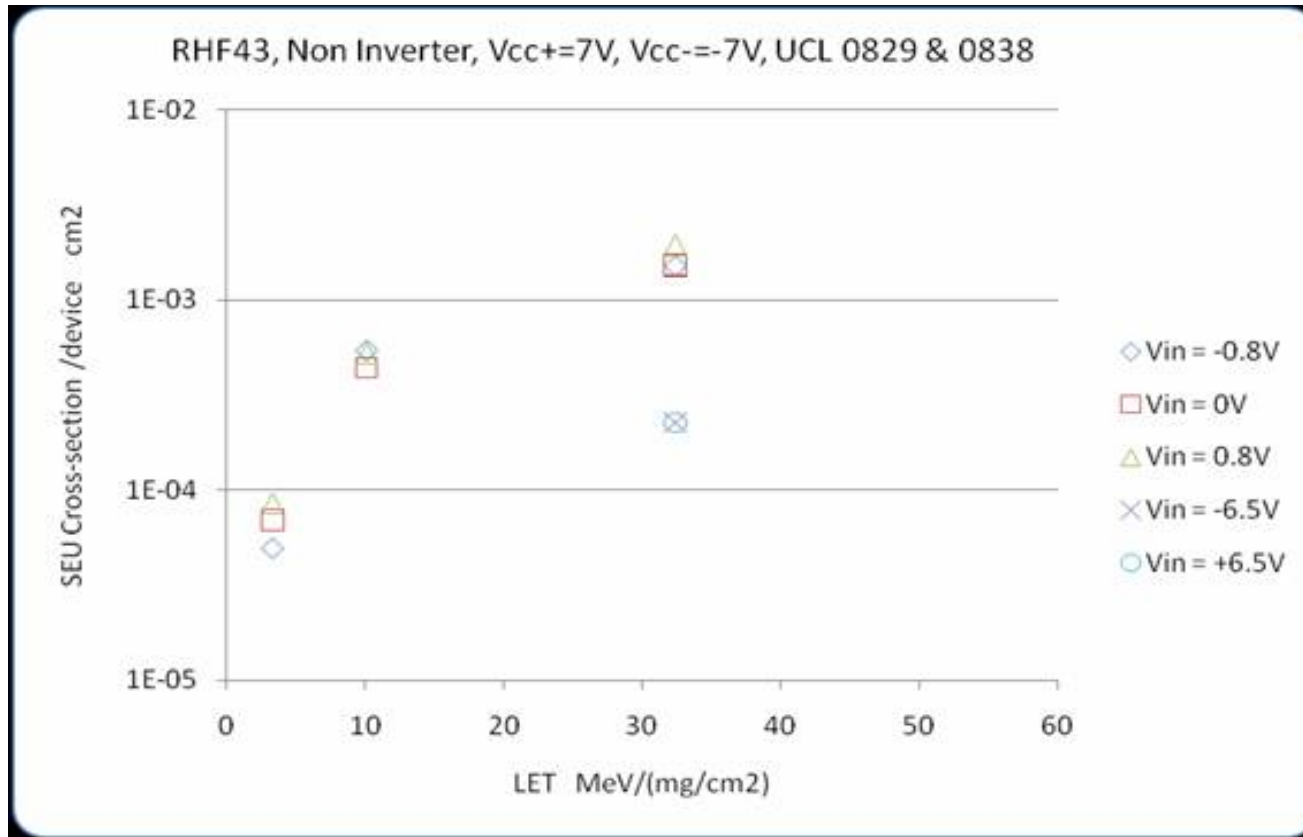


Saturated cross-section=2.04E-03cm²

LET_{th}=10.9MeV.cm²/mg

3. Experimental results

- RHF43B: Non-Inverting configuration



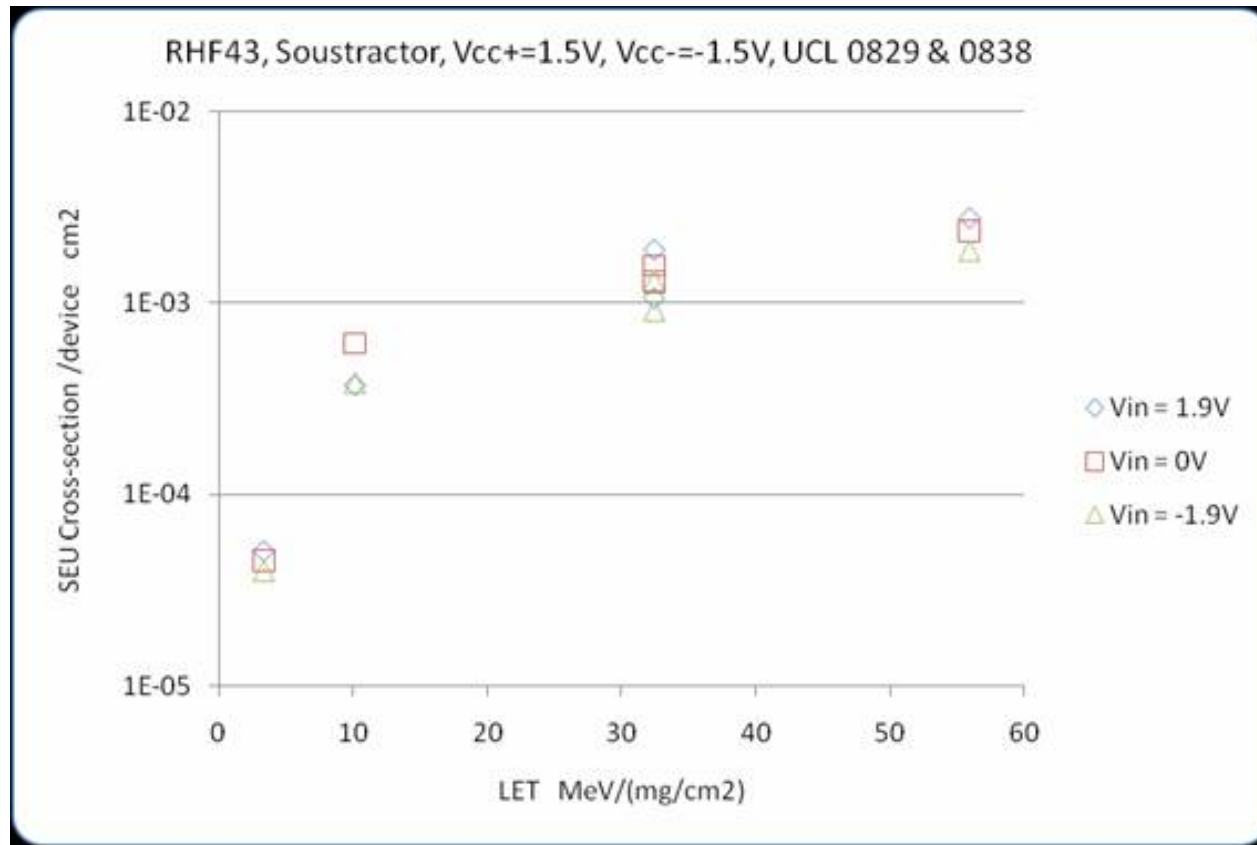
Saturated cross-section=1.17E-03cm²

LET_{th}=10.9MeV.cm²/mg

3. Experimental results



- RHF43B: Subtracting configuration



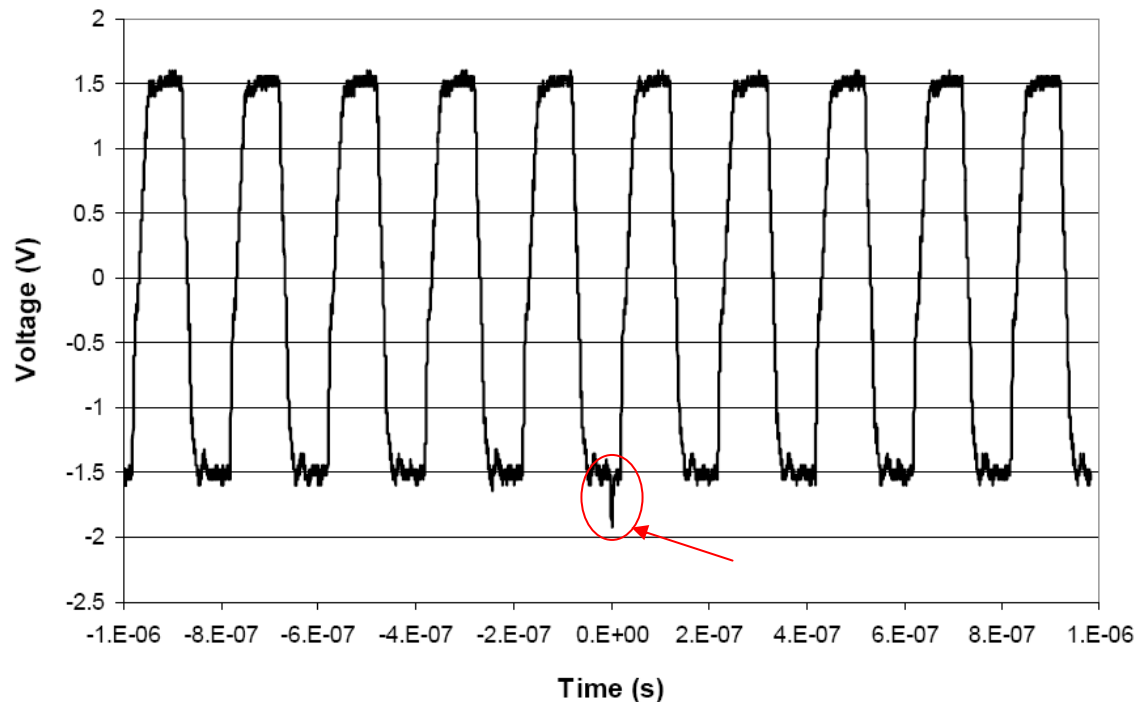
Saturated cross-section= $2.30\text{E-}03\text{cm}^2$

$\text{LET}_{\text{th}}=10.9\text{MeV.cm}^2/\text{mg}$

3. Experimental results



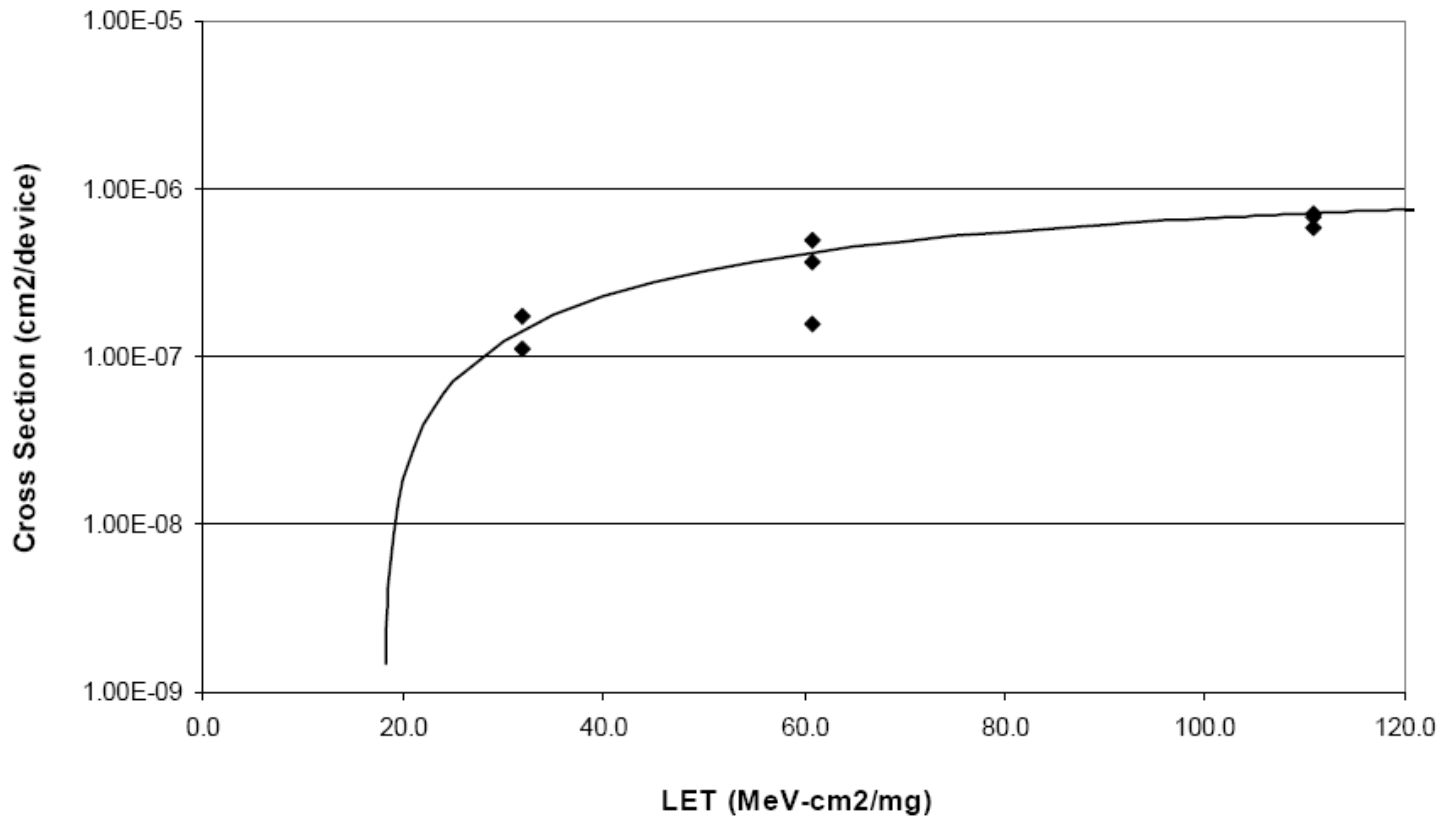
- RHF310:
 - No SEL @ 111MeV.cm²/mg, 125°C
 - SET :
 - No SET in Inverting configuration
 - Very little SET in Non-Inverting and Subtracting configurations



3. Experimental results



- RHF310: Non-Inverting configuration



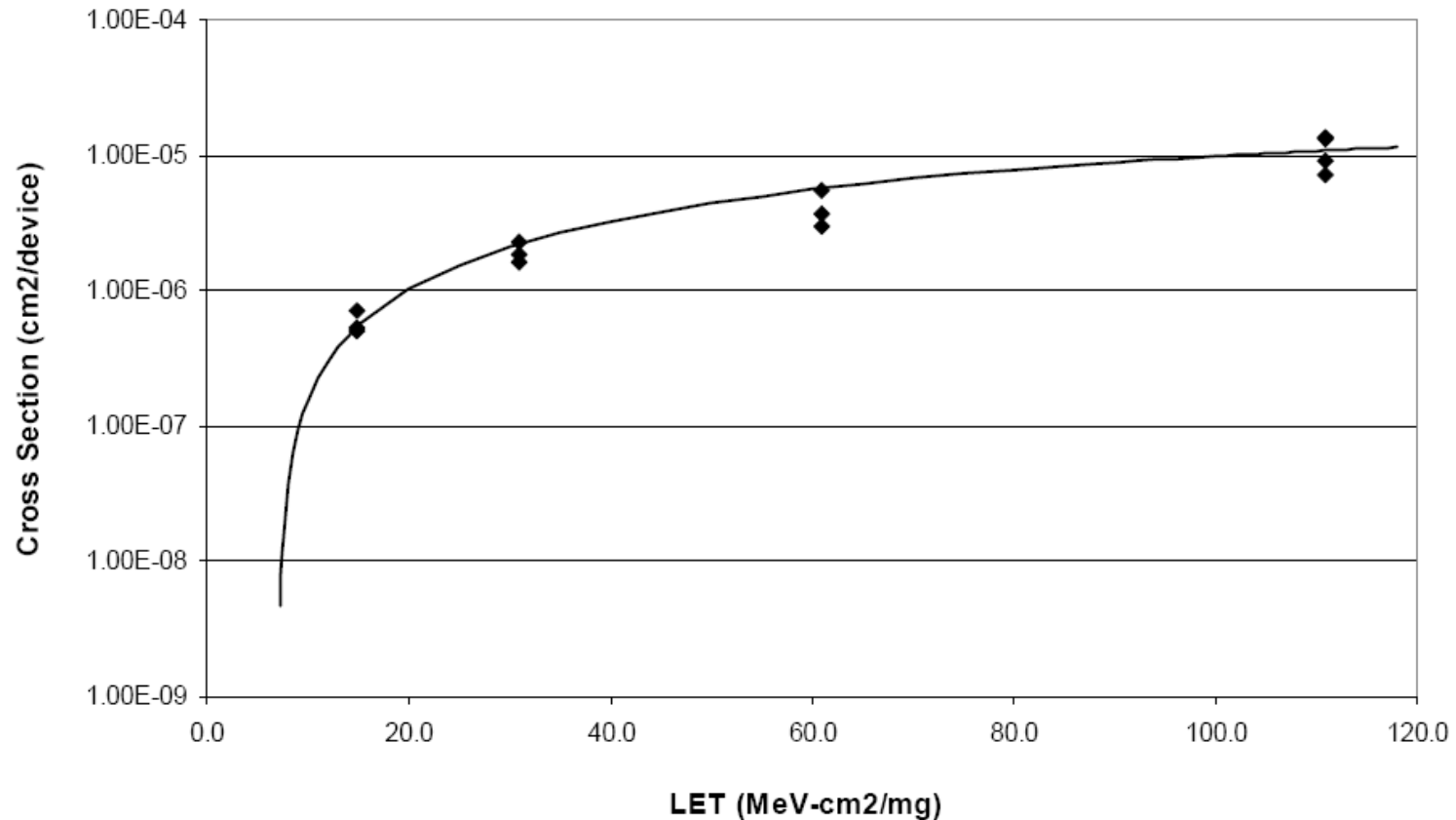
Saturated cross-section=1.00E-06cm²/device

LET_{th}=18MeV.cm²/mg

3. Experimental results



- RHF310: Subtracting configuration



Saturated cross-section=2.00E-05cm²

LET_{th}=7MeV.cm²/mg

- Similar heavy ions tests have been done on RHF43B and RHF310 operational amplifiers.
- RHF43B and RHF310 are **SEL immune** for a $LET = 110\text{MeV.cm}^2/\text{mg}$ @ 125°C
- RHF310 has a better behavior in term of SET : immunity in Inverting configuration, saturated cross-sections $> 2.00\text{E-}05\text{cm}^2$ for Non-Inverting and Subtracting configurations.